

<b>Notice of References Cited</b>	Application/Control No. 10/525,706	Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner LUAN V. VAN	Art Unit 1795	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-4,566,952	01-1986	Sprintschnik et al.	430/278.1
*	C	US-2003/0031438	02-2003	Kambe et al.	385/122
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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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